



FQB34N20 / FQI34N20

200V N-Channel MOSFET

General Description

These N-Channel enhancement mode power field effect transistors are produced using Fairchild's proprietary, planar stripe, DMOS technology.

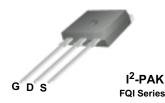
This advanced technology has been especially tailored to minimize on-state resistance, provide superior switching performance, and withstand high energy pulse in the avalanche and commutation mode. These devices are well suited for high efficiency switching DC/DC converters, switch mode power supply, DC-AC converters for uninterrupted power supply, motor control.

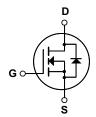
Features

- 31A, 200V, $R_{DS(on)} = 0.075\Omega @V_{GS} = 10 V$
- Low gate charge (typical 60 nC)
- Low Crss (typical 55 pF)
- Fast switching
- 100% avalanche tested
- · Improved dv/dt capability
- · RoHS Compliant









Absolute Maximum Ratings T_C = 25°C unless otherwise noted

Symbol	Parameter		FQB34N20 / FQI34N20	Units
V _{DSS}	Drain-Source Voltage		200	V
I _D	Drain Current - Continuous (T _C = 25°C)		31	Α
	- Continuous (T _C = 100°C)	·	20	Α
I _{DM}	Drain Current - Pulsed	(Note 1)	124	Α
V_{GSS}	Gate-Source Voltage		± 30	V
E _{AS}	Single Pulsed Avalanche Energy	(Note 2)	640	mJ
I _{AR}	Avalanche Current	(Note 1)	31	Α
E _{AR}	Repetitive Avalanche Energy	(Note 1)	18	mJ
dv/dt	Peak Diode Recovery dv/dt	(Note 3)	5.5	V/ns
P _D	Power Dissipation (T _A = 25°C) *		3.13	W
_	Power Dissipation (T _C = 25°C)		180	W
	- Derate above 25°C		1.43	W/°C
T_J, T_{STG}	Operating and Storage Temperature Range		-55 to +150	°C
T _L	Maximum lead temperature for soldering purposes, 1/8" from case for 5 seconds		300	°C

Thermal Characteristics

Symbol	Parameter	Тур	Max	Units
$R_{\theta JC}$	Thermal Resistance, Junction-to-Case		0.7	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient *		40	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient		62.5	°C/W

^{*} When mounted on the minimum pad size recommended (PCB Mount)

BV _{DSS} Δ BV _{DSS} / Δ T _J I _{DSS}	Practeristics Drain-Source Breakdown Voltage Breakdown Voltage Temperature					
BV _{DSS} Δ BV _{DSS} / Δ T _J I _{DSS}	Drain-Source Breakdown Voltage					
ΔBV _{DSS} / ΔT _J I _{DSS}	~	V _{GS} = 0 V, I _D = 250 μA	200			V
	Coefficient	I _D = 250 μA, Referenced to 25°C	:	0.2		V/°C
	Zero Gate Voltage Drain Current	V _{DS} = 200 V, V _{GS} = 0 V			1	μΑ
		V _{DS} = 160 V, T _C = 125°C			10	μΑ
I _{GSSF}	Gate-Body Leakage Current, Forward	V _{GS} = 30 V, V _{DS} = 0 V			100	nA
I _{GSSR}	Gate-Body Leakage Current, Reverse	V _{GS} = -30 V, V _{DS} = 0 V			-100	nA
On Char	acteristics					
	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_{D} = 250 \mu\text{A}$	3.0		5.0	V
R _{DS(on)}	Static Drain-Source On-Resistance	V _{GS} = 10 V, I _D = 15.5 A		0.06	0.075	Ω
9 _{FS}	Forward Transconductance	V _{DS} = 40 V, I _D = 15.5 A (Note 4		25		S
C _{oss}	Input Capacitance Output Capacitance Reverse Transfer Capacitance	$V_{DS} = 25 \text{ V}, V_{GS} = 0 \text{ V},$ f = 1.0 MHz		430 55	3100 560 70	pF pF
C _{rss}	Reverse Transfer Capacitance		-	55	70	p⊦
	ng Characteristics					T
۵(۵)	Turn-On Delay Time	V _{DD} = 100 V, I _D = 34 A,		40	90	ns
t _r	Turn-On Rise Time	$R_G = 25 \Omega$		280	570	ns
۵(۵)	Turn-Off Delay Time	(Note 4 5		125	260	ns
	Turn-Off Fall Time	(Note 4, 5	''	115	240	ns
3	Total Gate Charge	V _{DS} = 160 V, I _D = 34 A,		60	78	nC
3-	Gate-Source Charge	V _{GS} = 10 V		17		nC
Q_{gd}	Gate-Drain Charge	(Note 4, 5		27		nC
Drain Ca	ourse Diede Characteristics or	ed Mayimum Datinga				
	Durce Diode Characteristics ar Maximum Continuous Drain-Source Dio				31	Α
	Maximum Pulsed Drain-Source Diode Forward Current		+ -		124	A
0	Drain-Source Diode Forward Voltage	V _{GS} = 0 V, I _S = 31 A			1.5	V
		$V_{GS} = 0 \text{ V, } I_S = 31 \text{ A}$ $V_{GS} = 0 \text{ V, } I_S = 34 \text{ A,}$		150	1.5	ns
_	Reverse Recovery Time Reverse Recovery Charge	$dI_F / dt = 100 \text{ A/µs}$ (Note 4)		0.95		μC

- Notes: 1. Repetitive Rating : Pulse width limited by maximum junction temperature 2. L = 1.0mH, I_{AS} = 31A, V_{DD} = 50V, R_{G} = 25 Ω , Starting T_{J} = 25°C 3. $I_{SD} \le$ 34A, di/dt \le 300A/µs, $V_{DD} \le$ BVDSS, Starting T_{J} = 25°C 4. Pulse Test : Pulse width \le 300µs, Duty cycle \le 2% 5. Essentially independent of operating temperature

Typical Characteristics

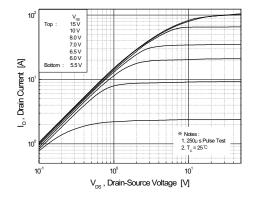


Figure 1. On-Region Characteristics

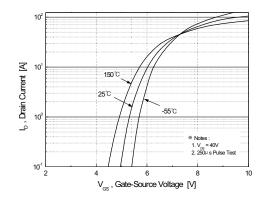


Figure 2. Transfer Characteristics

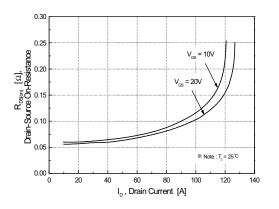


Figure 3. On-Resistance Variation vs. Drain Current and Gate Voltage

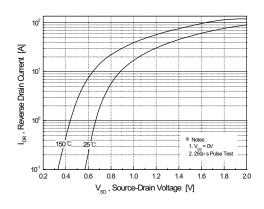


Figure 4. Body Diode Forward Voltage Variation vs. Source Current and Temperature

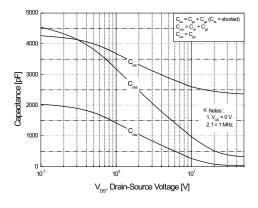


Figure 5. Capacitance Characteristics

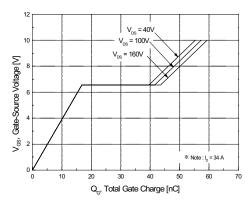
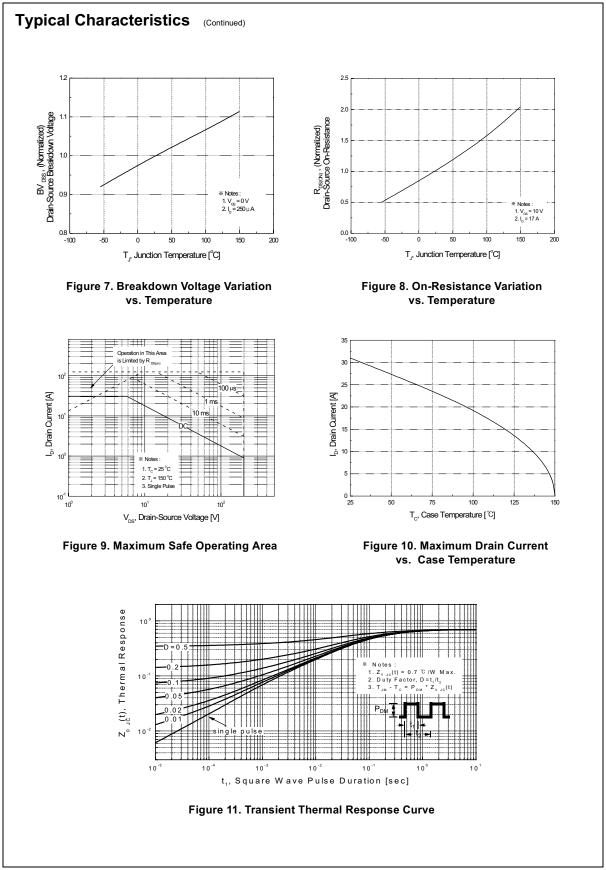
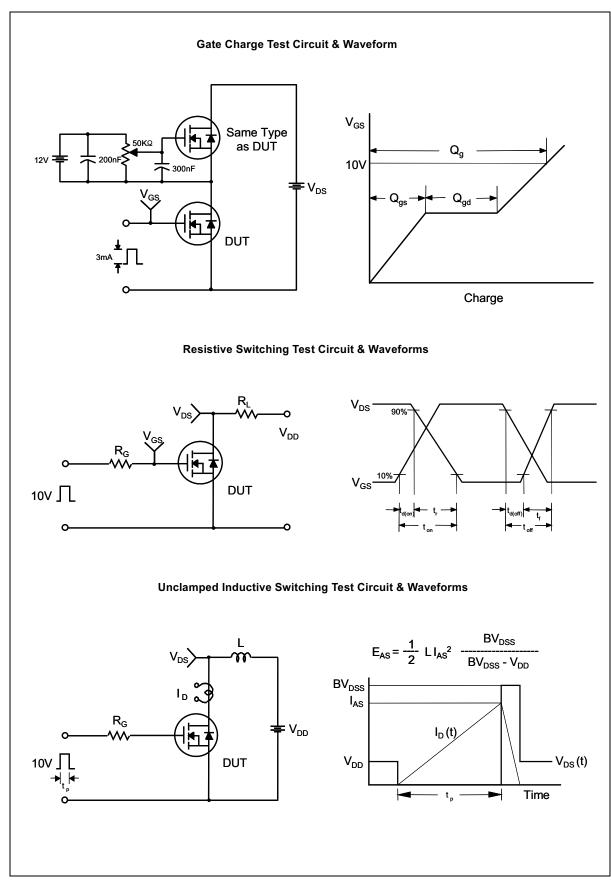
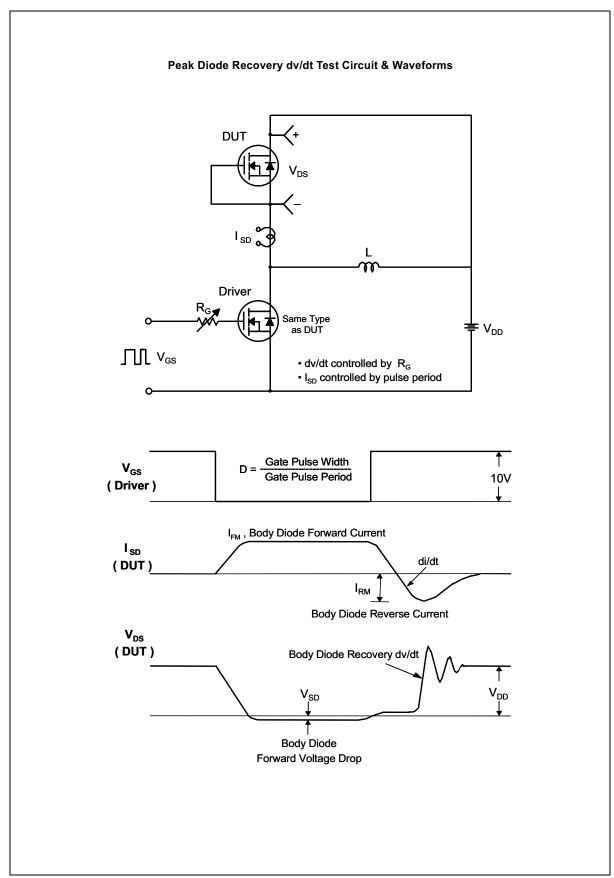


Figure 6. Gate Charge Characteristics



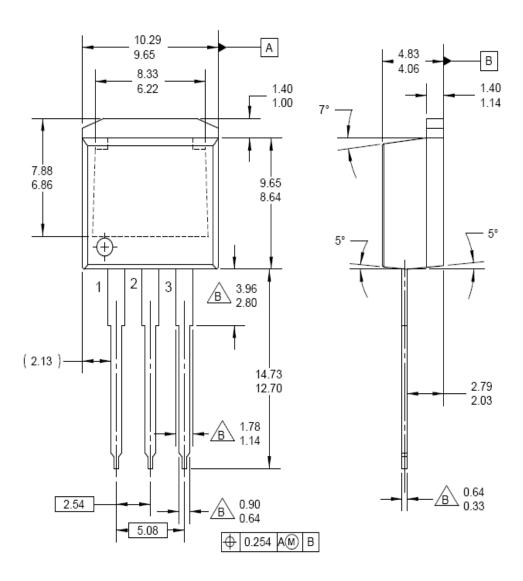


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Mechanical Dimensions

I² - PAK



Dimensions in Millimeters

Mechanical Dimensions D² - PAK -A-10.67 9.65 9.50 MIN 9.00 MIN 1.78 MAX 10.00 (2.12) -1.50 MIN 5.08 → 0.25 M B AM 5.08 LAND PATTERN RECOMMENDATION -B-6.22 MIN-6.86 MIN 15.88 14.61 SEE DETAIL A GAGE PLANE 0.25 ○ 0.10 B .25 MAX -SEATING DETAIL Dimensions in Millimeters





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